

MOSFET Silicon N-Channel MOS

1. Applications

For half bridge or Asymmetric half bridge or Series resonance half bridge topologies
Such as Server power, Telecom power, EV Charging.



2. Features

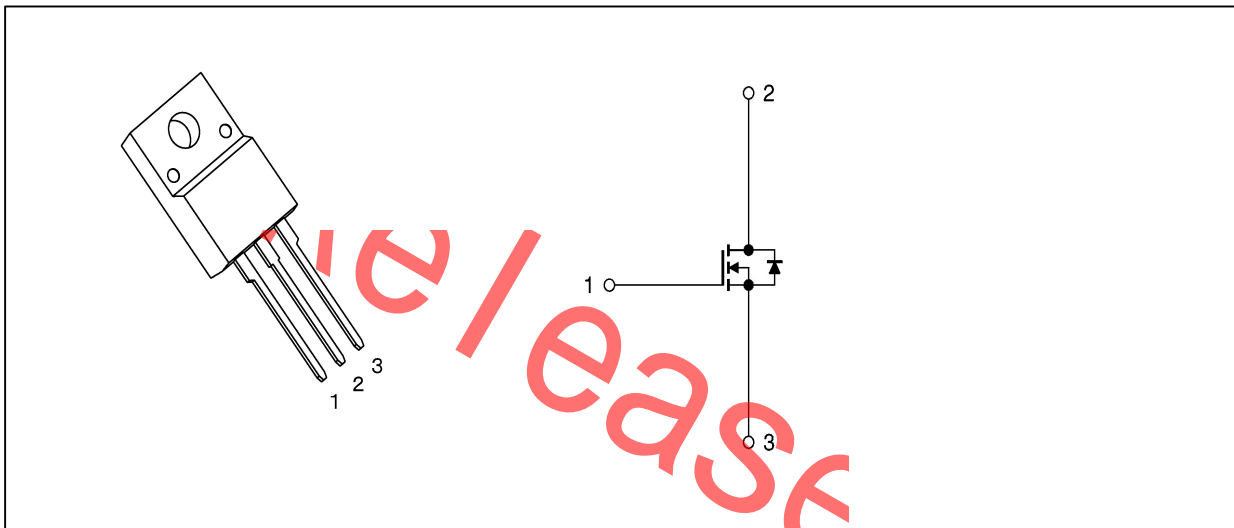
Low drain-source on-resistance: $R_{DS(ON)} = 0.140\Omega$ (typ.)
Easy to control Gate switching
Enhancement mode: $V_{th} = 3$ to 5 V



Table 1 Key Performance Parameters

Parameter	Value	Unit
$V_{DS} @ T_{j,max}$	650	V
$R_{DS(on),max}$	180	m Ω
$Q_{g,typ}$	47.59	nC
$I_{D,pulse}$	84	A
Body diode dv/dt	50	V/ns

3. Packaging and Internal Circuit



1 Maximum ratings

at $T_j = 25^\circ\text{C}$, unless otherwise specified

Table 2 Maximum ratings

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Continuous drain current ¹⁾	I_D		-	28	A	$T_C = 25^\circ\text{C}$
Pulsed drain current ²⁾	$I_{D,pulse}$	-	-	84	A	$T_C = 25^\circ\text{C}$
Avalanche energy, single pulse	E_{AS}	-	-	898	mJ	
MOSFET dv/dt ruggedness	dv/dt	-	-	130	V/ns	$V_{DS} = 0 \dots 400\text{V}$
Gate source voltage (static)	V_{GS}	-20	-	20	V	static;
Gate source voltage (dynamic)	V_{GS}	-30	-	30	V	AC ($f > 1\text{ Hz}$)
Power dissipation	P_{tot}	-	-	34	W	$T_C = 25^\circ\text{C}$
Storage temperature	T_{stg}	-55	-	150	$^\circ\text{C}$	
Operating junction temperature	T_j	-55	-	150	$^\circ\text{C}$	
Reverse diode dv/dt ³⁾	dv/dt	-	-	50	V/ns	$V_{DS} = 0 \dots 400\text{V}$, $I_{SD} \leq 48\text{A}$, $T_j = 25^\circ\text{C}$ see table 8

¹⁾ Limited by $T_{j,max}$. Maximum Duty Cycle $D = 0.50$

²⁾ Pulse width t_p limited by $T_{j,max}$

³⁾ Identical low side and high side switch with identical R_G

Not for release

2 Thermal characteristics

Table 3 Thermal characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Thermal resistance, junction - case	R_{thJC}	-	-	3.7	°C/W	-
Thermal resistance, junction - ambient	R_{thJA}	-	-	80	°C/W	device on PCB, minimal footprint

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3 Electrical characteristics

at $T_j=25^{\circ}\text{C}$, unless otherwise specified

Table 4 Static characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Drain-source breakdown voltage	$V_{(BR)DSS}$	605	-	-	V	$V_{GS}=0\text{V}$, $I_D=10\text{mA}$
Gate threshold voltage	$V_{(GS)th}$	3		5	V	$V_{DS}=V_{GS}$, $I_D=250\mu\text{A}$
Zero gate voltage drain current	I_{DSS}	-	-	5	μA	$V_{DS}=600\text{V}$, $V_{GS}=0\text{V}$, $T_j=25^{\circ}\text{C}$
Gate-source leakage current	I_{GSS}	-	-	100	nA	$V_{GS}=30\text{V}$, $V_{DS}=0\text{V}$
Drain-source on-state resistance	$R_{DS(on)}$	-	0.14	0.18	Ω	$V_{GS}=10\text{V}$, $I_D=10\text{A}$, $T_j=25^{\circ}\text{C}$
Gate resistance (Intrinsic)	R_G	-	5.8	-	Ω	$f=1\text{MHz}$, open drain

Table 5 Dynamic characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Input capacitance	C_{iss}	-	2389	-	pF	$V_{GS}=0\text{V}$, $V_{DS}=50\text{V}$, $f=10\text{kHz}$
Output capacitance	C_{oss}	-	218	-	pF	$V_{GS}=0\text{V}$, $V_{DS}=50\text{V}$, $f=10\text{kHz}$
Reverse transfer capacitance	C_{rss}	-	5.07	-	pF	$V_{GS}=0\text{V}$, $V_{DS}=50\text{V}$, $f=10\text{kHz}$
Turn-on delay time	$t_{d(on)}$	-	12.4	-	ns	$V_{DD}=400\text{V}$, $V_{GS}=13\text{V}$, $I_D=11.3\text{A}$, $R_G=1.7\Omega$; see table 9
Rise time	t_r	-	21.6	-	ns	$V_{DD}=400\text{V}$, $V_{GS}=13\text{V}$, $I_D=11.3\text{A}$, $R_G=1.7\Omega$; see table 9
Turn-off delay time	$t_{d(off)}$	-	50	-	ns	$V_{DD}=400\text{V}$, $V_{GS}=13\text{V}$, $I_D=11.3\text{A}$, $R_G=1.7\Omega$; see table 9
Fall time	t_f	-	18.4	-	ns	$V_{DD}=400\text{V}$, $V_{GS}=13\text{V}$, $I_D=11.3\text{A}$, $R_G=1.7\Omega$; see table 9

Table 6 Gate charge characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Gate to source charge	Q_{gs}	-	8.522	-	nC	$V_{DD}=400\text{V}$, $I_D=11.3\text{A}$, $V_{GS}=0$ to 10V
Gate to drain charge	Q_{gd}	-	8.297	-	nC	$V_{DD}=400\text{V}$, $I_D=11.3\text{A}$, $V_{GS}=0$ to 10V
Gate charge total	Q_g	-	47.59	-	nC	$V_{DD}=400\text{V}$, $I_D=11.3\text{A}$, $V_{GS}=0$ to 10V
Gate plateau voltage	$V_{plateau}$	-	5.4	-	V	$V_{DD}=400\text{V}$, $I_D=11.3\text{A}$, $V_{GS}=0$ to 10V

Table 7 Reverse diode characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Diode forward voltage	V_{SD}	-	0.69	-	V	$V_{GS}=0V, I_F=1A, T_j=25^{\circ}C$
Reverse recovery time	t_{rr}	-	115	-	ns	$V_r=400v, I_F=7A, di/dt=100A/us$ see table 8
Reverse recovery charge	Q_{rr}	-	0.623	-	uC	$V_r=400v, I_F=7A, di/dt=100A/us$ see table 8
Peak reverse recovery current	I_{rrm}	-	10.3	-	A	$V_r=400v, I_F=7A, di/dt=100A/us$ see table 8

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4 Test Circuits

Table 8 Diode characteristics

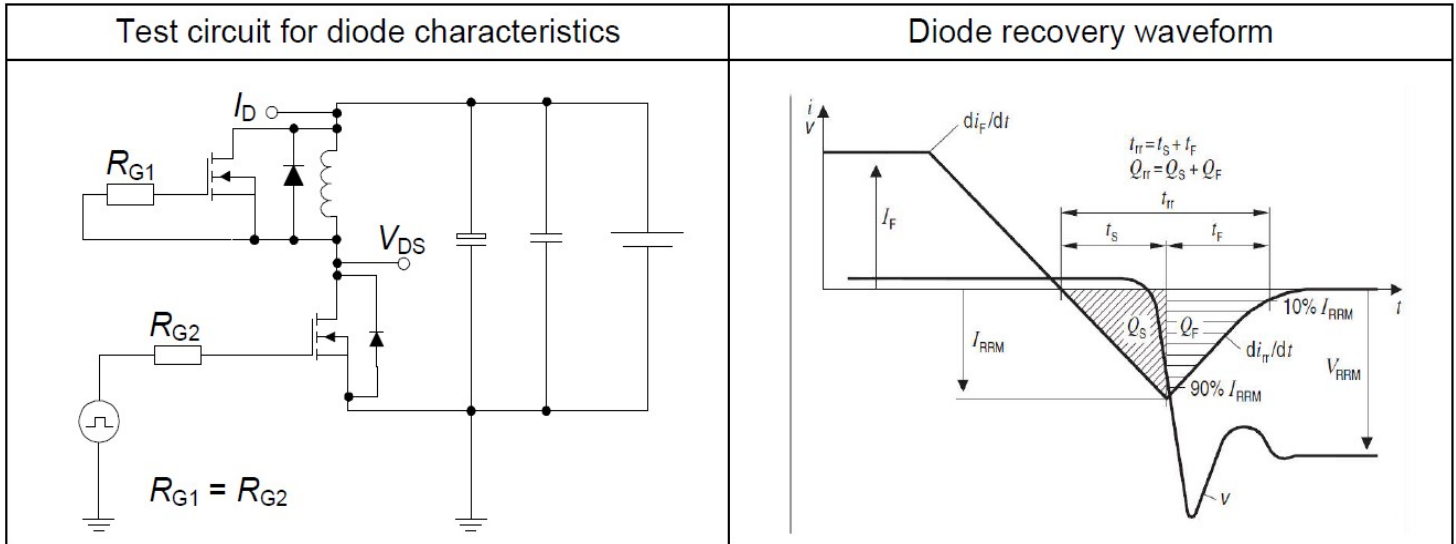


Table 9 Switching times

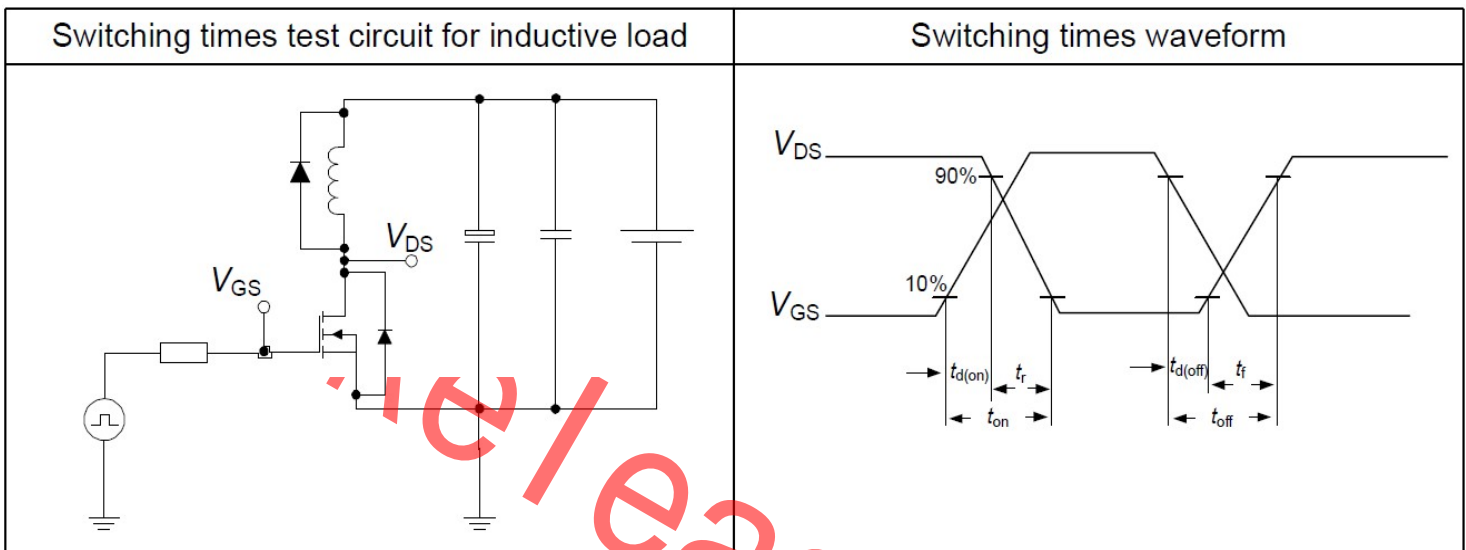
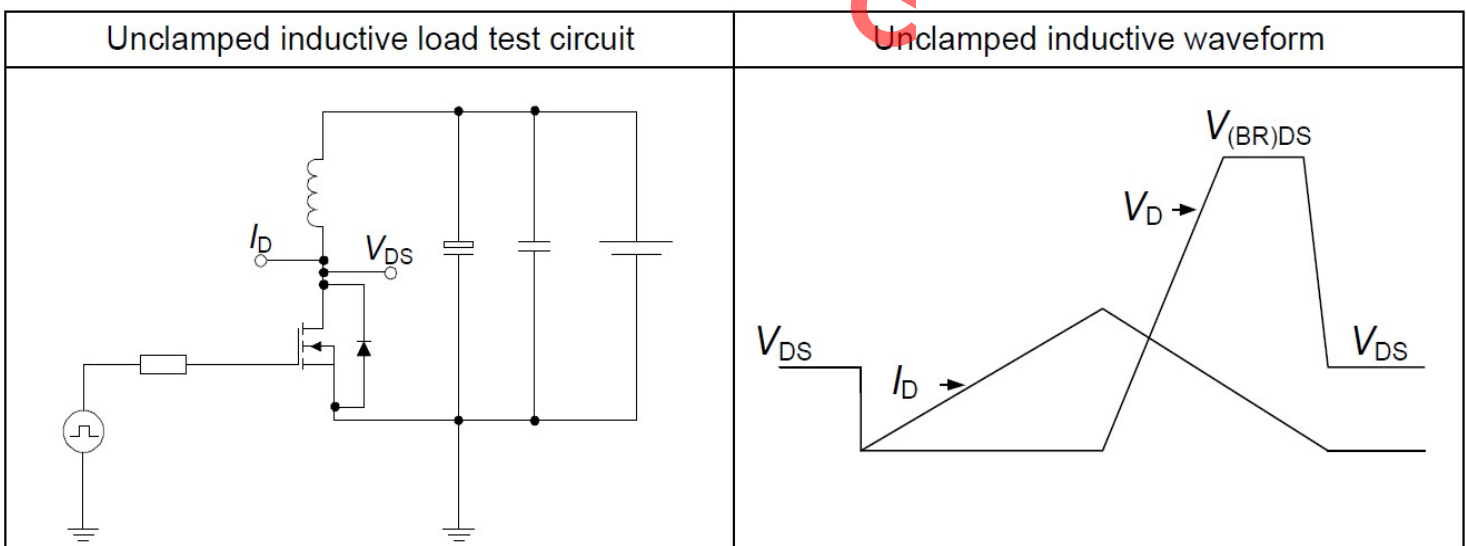


Table 10 Unclamped inductive load



5 Package Outlines

TO-220F

单位: mm

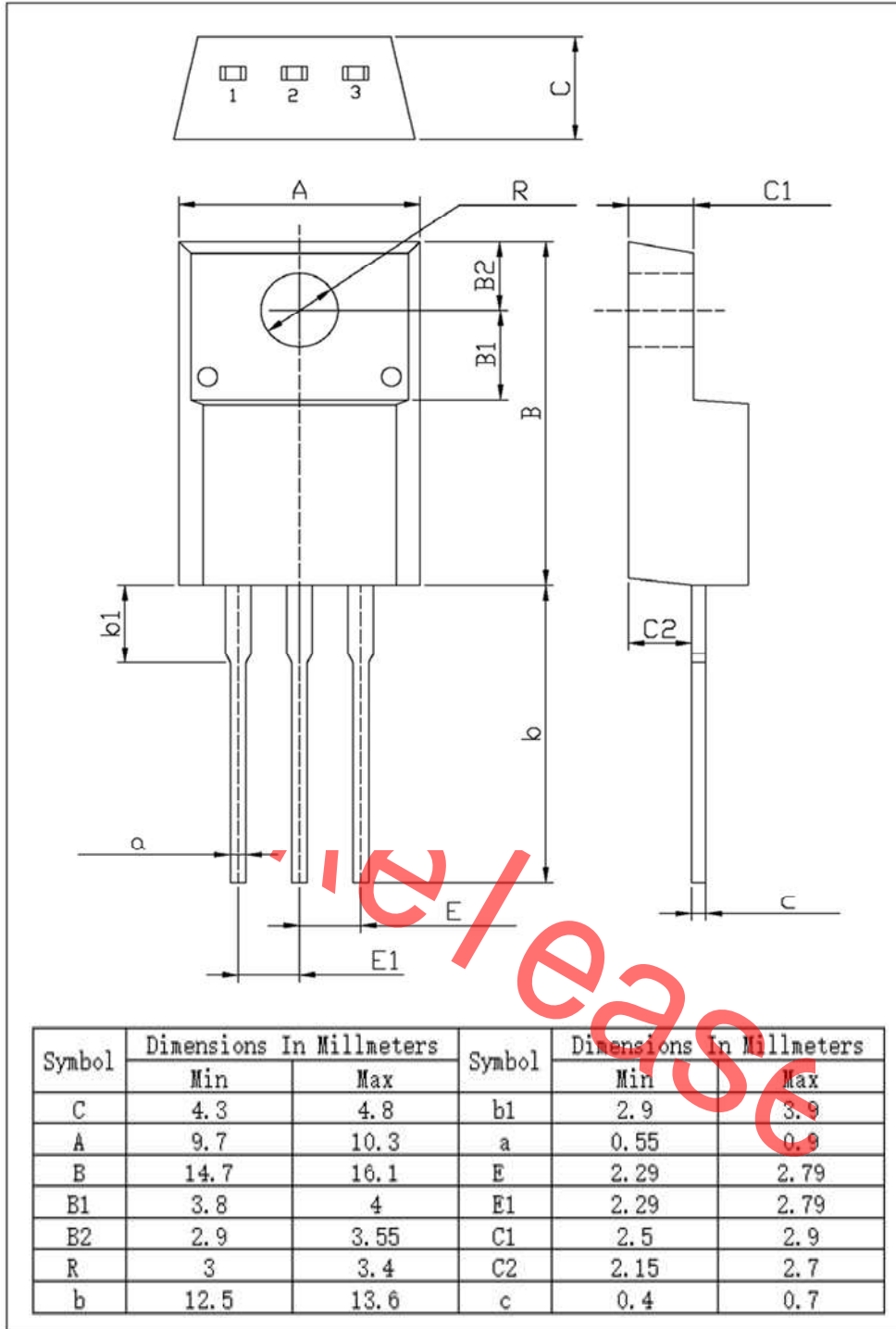


Figure1: Outline PG-TO220F

Revision History

ASA60R180EFD

Revision	Date	Subjects (major changes since last revision)
0.1	2019-05-21	Preliminary version
1.0	2019-11-07	Fine tune outline and add Crss test data.etc

Pre-release